## Search Notes



1,46

564,565

386

348

Application/Control N	ο.
Application/Control II	٠.

10814198

Applicant(s)/Patent Under Reexamination

Examiner

MC

MC

YOON ET AL.

12/20/2008

12/20/2008

Art Unit 2621

Examiner Michael Choi

	SEARCHED	
Class	Subclass	Date

SEARCH NOTES		
Search Notes	Date	Examiner
Updated Inventor search in eDan	12/20/2008	MC
Updated EAST Search History	12/20/2008	MC

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

/Michael Choi/ Examiner.Art Uni	t 2621		

U.S. Patent and Trademark Office Part of Paper No.: 20081220